

Notice of References Cited	Application/Control No. 10/544,215		Applicant(s)/Patent Under Reexamination MAGYAR ET AL.	
	Examiner Chuck Mah		Art Unit 3677	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,870,493 A	01-1959	BEYRL THOMAS T	49/460
*	B	US-5,144,718 A	09-1992	Ozawa, Akio	16/412
*	C	US-5,797,164 A	08-1998	Donaghy, David J.	16/412
*	D	US-6,000,097 A	12-1999	Russell, Brian G.	16/114.1
*	E	US-6,430,780 B1	08-2002	Kim et al.	16/412
*	F	US-6,507,978 B1	01-2003	Root et al.	16/410
*	G	US-2006/0200948 A1	09-2006	Steurer, Brian Michael	016/412
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	CH 680323 A5	07-1992	Switzerland	WUEST, ERNST	F16M 03/00
	O	JP 2002005561 A	01-2002	Japan	IWABUCHI et al.	F25D 23/02
	P	JP 2003194455 A	07-2003	Japan	SON, MIN-GU	F25D 23/02
	Q	JP 2004347216 A	12-2004	Japan	AZUMAGUCHI, KEIICHI	F25D 23/02
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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